Power MOSFET 40 V, 0.82 mΩ, 330 A, Single N–Channel

Features

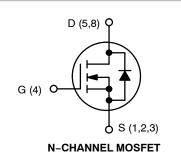
- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- LFPAK8 Package, Industry Standard
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

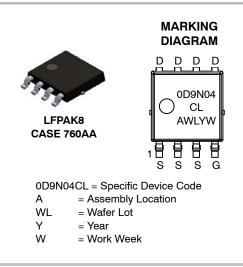


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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	$0.82~\mathrm{m}\Omega$ @ 10 V	000 4
40 V	1.2 mΩ @ 4.5 V	330 A





ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage	e		V _{GS}	±20	V
Continuous Drain	Steady	T _C = 25°C	۱ _D	330	А
Current R _{θJC} (Notes 1, 3)	State	T _C = 100°C		230	
Power Dissipation		$T_{C} = 25^{\circ}C$	PD	167	W
R _{θJC} (Note 1)		T _C = 100°C		83	
Continuous Drain	Steady State	$T_A = 25^{\circ}C$	Ι _D	50	А
Current R _{θJA} (Notes 1, 2, 3)	Sidle	T _A = 100°C		35	
Power Dissipation		$T_A = 25^{\circ}C$	PD	3.8	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		1.9	1
Pulsed Drain Current	$T_A = 25^{\circ}C$, $t_p = 10 \ \mu s$		I _{DM}	900	А
Operating Junction and Storage Temperature Range			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			I _S	169	А
Single Pulse Drain-to-Source Avalanche Energy ($I_{L(pk)} = 29 A$)			E _{AS}	706	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.9	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	36	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

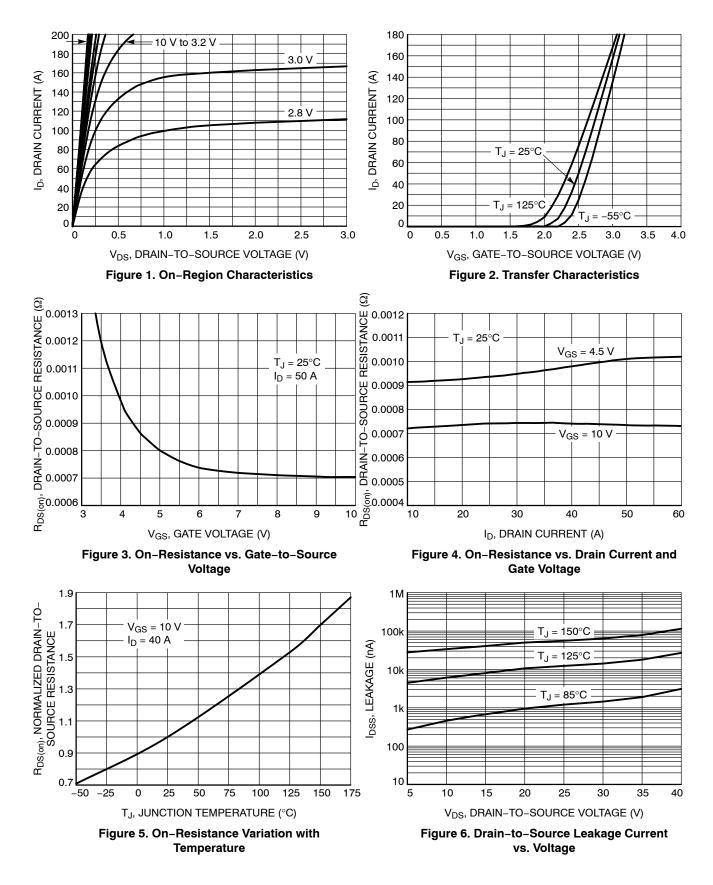
3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

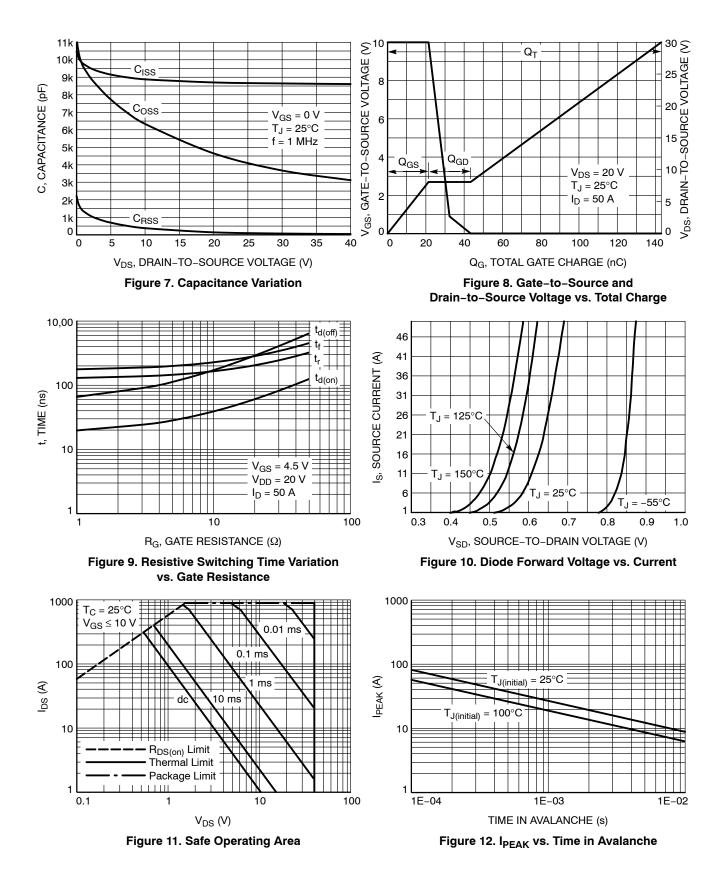
Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 µA		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				18		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25 °C			10	μA
		V _{DS} = 40 V	T _J = 125°C			250	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _G	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 190 μA	1.2		2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 50 A		0.65	0.82	mΩ
		V _{GS} = 4.5 V	I _D = 50 A		0.95	1.2	
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I _E	₀ = 50 A		190		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE			-		-	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			8862		pF
Output Capacitance	C _{OSS}				3328		
Reverse Transfer Capacitance	C _{RSS}				77		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 4.5 V, V_{DS} = 20 V; I_{D} = 50 A			66		nC
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 10 \text{ V}, V_{DS} = 20 \text{ V}; \text{ I}_{D} = 50 \text{ A}$ $V_{GS} = 4.5 \text{ V}, V_{DS} = 20 \text{ V}; \text{ I}_{D} = 50 \text{ A}$			143		-
Threshold Gate Charge	Q _{G(TH)}				6.75		
Gate-to-Source Charge	Q _{GS}				21.4		
Gate-to-Drain Charge	Q _{GD}				22		
Plateau Voltage	V _{GP}				2.7		V
SWITCHING CHARACTERISTICS (Note &	5)						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 V, V_{D}$	_S = 20 V,		20		ns
Rise Time	t _r	$I_D = 50 \text{ A}, \text{ R}_G$	= 1.0 Ω		130		1
Turn-Off Delay Time	t _{d(OFF)}				66		1
Fall Time	t _f				177		
DRAIN-SOURCE DIODE CHARACTERIS	TICS				•		
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.73	1.2	V
		I _S = 50 A	T _J = 125°C		0.6		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt			79.5		ns
Charge Time	t _a	$I_{\rm S} = 50 \rm A$			39		
Discharge Time	t _b				40.5		
Reverse Recovery Charge	Q _{RR}	1		L	126		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2%. 5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

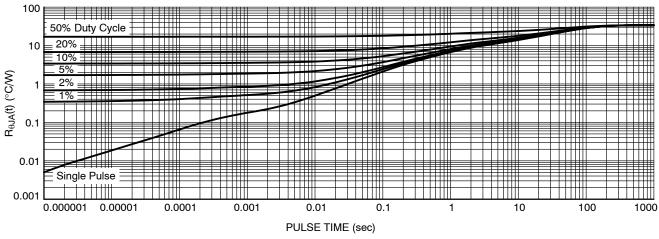


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

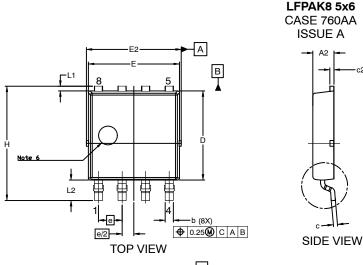
Device	Marking	Package	Shipping [†]
NVMJS0D9N04CLTWG	0D9N04CL	LFPAK8 (Pb–Free)	3000 / Tape & Reel

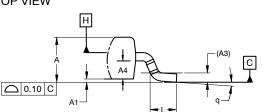
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

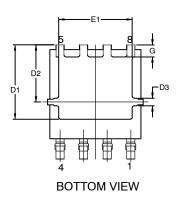
A2

c2





DETAIL 'A'



	4.5		5	
Ŕ				0.700
2.055			× 1	0.595
				0.600
0.700 R	×××××××		×××	1.060
1.150				Ŧ
0.700 1 (8X)			4	
RECOMMENDED MOUNTING				

FOOTPRINT

NOTES:

- DIMENSIONING AND TOLERANCING 1.
- PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: 2.
- MILLIMETERS. 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- DIMENSIONS D AND E ARE 4. DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DATUMS A AND B ARE DETERMINED AT DATUM PLANE H. 5.
- OPTIONAL MOLD FEATURE. 6.

MILLIMETERS					
DIM	MIN NOM MAX				
Α	1.10	1.20	1.30		
A1	0.00	0.08	0.15		
A2	1.10	1.15	1.20		
A3	().25 REF			
A4	0.45	0.50	0.55		
b	0.40	0.45	0.50		
С	0.19	0.22	0.25		
c2	0.19	0.22	0.25		
D	4.70	4.80	4.90		
D1	1	I	4.20		
D2	3.00	3.10	3.20		
D3	0.30	0.40	0.50		
Е	4.80	4.90	5.00		
E1	3.90	4.00	4.10		
E2	5.00	5.15	5.30		
е	1.27 BSC				
G	0.55	0.65	0.75		
Н	6.00	6.15	6.30		
L	0.40	0.65	0.85		
L1	0.15	0.25	0.35		
L2	0.80	1.05	1.30		
q	0°	4°	8°		

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